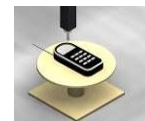




PCTEST ENGINEERING LABORATORY, INC.

6660-B Dobbin Road, Columbia, MD 21045 USA
Tel. 410.290.6652 / Fax 410.290.6654
http://www.pctestlab.com



HEARING AID COMPATIBILITY

Applicant Name:
Samsung Electronics Co., Ltd.
416 Maetan 3-Dong, Yeongtong-gu, Suwon-si
Gyeonggi-do, 443-742, Republic of Korea

Date of Testing:
7/3/2012
Test Site/Location:
PCTEST Lab, Columbia, MD, USA
Test Report Serial No.:
0Y1206260859.A3L

FCC ID: A3LSPHM950

APPLICANT: SAMSUNG ELECTRONICS CO., LTD.


Scope of Test: Audio Band Magnetic Testing (T-Coil)
Application Type: Certification
FCC Rule Part(s): CFR § 20.19(b)
HAC Standard: ANSI C63.19-2007 §6.3(v), §7.3(v)
EUT Type: Portable Handset
Model(s): SPH-M950
Tx Frequencies Tested: 1851.25 - 1908.75 MHz (PCS CDMA)
Test Device Serial No.: Pre-Production Sample [S/N: SAR/HAC#2]

C63.19-2007 HAC Category: T4 (SIGNAL TO NOISE CATEGORY)

This wireless portable device has been shown to be hearing-aid compatible under the above rated category, specified in ANSI/IEEE Std. C63.19-2007 and had been tested in accordance with the specified measurement procedures. Hearing-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report. Test results reported herein relate only to the item(s) tested. For North American bands only.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

PCTEST certifies that no party to this application has been subject to a denial of Federal benefits that includes FCC benefits pursuant to Section 5301 of the Anti-Drug Abuse Act of 1988, 21 U.S.C. 862.


Randy Ortanez
President







| | | | | |
|--------------------------------------|---|--------------------------------------|---|--|
| FCC ID: A3LSPHM950 |  | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | Page 1 of 37 | |

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|--------------------------------------|---|--------------------------------------|---|--|
| FCC ID: A3LSPHM950 |  <small>PROBATIONARY CONSULTING ENGINEERS</small> | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | Page 2 of 37 | |

1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658¹ to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. Approximately 500 million people worldwide and 30 million people in the United States suffer from hearing loss.

Compatibility Tests Involved:

The standard calls for wireless communications devices to be measured for:

- RF Electric-field emissions
- RF Magnetic-field emissions
- T-coil mode, magnetic-signal strength in the audio band
- T-coil mode, magnetic-signal frequency response through the audio band
- T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- RF immunity in microphone mode
- RF immunity in T-coil mode

In the following tests and results, this report includes the evaluation for a wireless communications device.

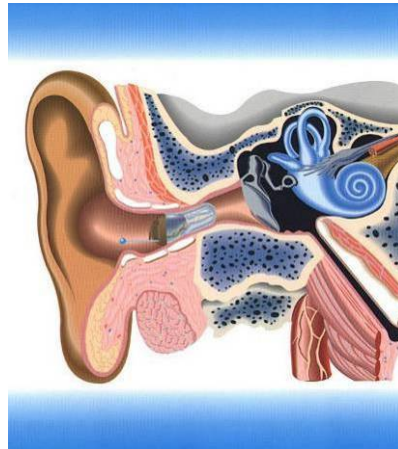




Figure 1-1 Hearing Aid *in-vitu*

¹ FCC Rule & Order, WT Docket 01-309 RM-8658

| | | | | |
|-------------------------------|---|-------------------------------|---|---------------------------------|
| FCC ID: A3LSPHM950 |  | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
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2. TEST SITE LOCATION

I. Introduction

The map at the right shows the location of the PCTEST LABORATORY in Columbia, Maryland. It is in proximity to the FCC Laboratory, the Baltimore-Washington International (BWI) airport, the city of Baltimore and Washington, DC (See Figure 2-1).

These measurement tests were conducted at the PCTEST Engineering Laboratory, Inc. facility in New Concept Business Park, Guilford Industrial Park, Columbia, Maryland. The site address is 6660-B Dobbin Road, Columbia, MD 21045. The test site is one of the highest points in the Columbia area with an elevation of 390 feet above mean sea level. The site coordinates are 39° 11'15" N latitude and 76° 49' 38" W longitude. The facility is 1.5 miles north of the FCC laboratory, and the ambient signal and ambient signal strength are approximately equal to those of the FCC laboratory. There are no FM or TV transmitters within 15 miles of the site. The detailed description of the measurement facility was found to be in compliance with the requirements of § 2.948 according to ANSI C63.4-2003 on January 27, 2006 and Industry Canada.

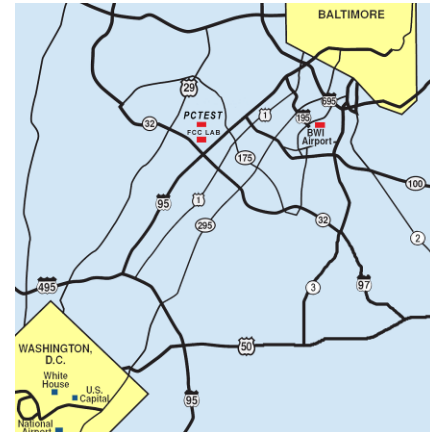
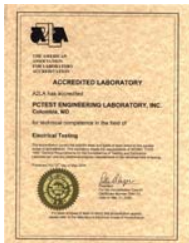




Figure 2-1
Map of the Greater Baltimore and Metropolitan Washington, D.C. Area

II. Test Facility / Accreditations:

Measurements were performed at an independent accredited PCTEST Engineering Lab located in Columbia, MD 21045, U.S.A.



- PCTEST Lab is accredited to ISO 17025-2005 by the American Association for Laboratory Accreditation (A2LA) in Specific Absorption Rate (SAR) testing, Hearing-Aid Compatibility (HAC), CTIA Test Plans, and wireless testing for FCC and Industry Canada Rules.
- PCTEST Lab is accredited to ISO 17025 by U.S. National Institute of Standards and Technology (NIST) under the National Voluntary Laboratory Accreditation Program (NVLAP Lab code: 100431-0) in EMC, FCC and Telecommunications.
- PCTEST facility is an FCC registered (PCTEST Reg. No. 90864) test facility with the site description report on file and has met all the requirements specified in Section 2.948 of the FCC Rules and Industry Canada (IC-2451).
- PCTEST Lab is a recognized U.S. Conformity Assessment Body (CAB) in EMC and R&TTE (n.b. 0982) under the U.S.-EU Mutual Recognition Agreement (MRA).
- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC Guide 65 by the American National Standards Institute (ANSI) in all scopes of FCC Rules and all Industry Canada Standards (RSS).
- PCTEST facility is an IC registered (IC-2451) test laboratory with the site description on file at Industry Canada.
- PCTEST is a CTIA Authorized Test Laboratory (CATL) for AMPS and CDMA, and EvDO mobile phones.
- PCTEST is a CTIA Authorized Test Laboratory (CATL) for Over-the-Air (OTA) Antenna Performance testing for AMPS, CDMA, GSM, GPRS, EGPRS, UMTS (W-CDMA), CDMA 1xEVDO Data, CDMA 1xRTT Data.

| | | | | |
|--------------------------------------|---|--------------------------------------|---|--|
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3. EUT DESCRIPTION



FCC ID: A3LSPHM950
 Applicant: Samsung Electronics Co., Ltd.
 416 Maetan 3-Dong, Yeongtong-gu, Suwon-si
 Gyeonggi-do, 443-742, Republic of Korea
 Model(s): SPH-M950
 Serial Number: SAR/HAC#2
 Tx Frequencies Tested: 1851.25 - 1908.75 MHz (PCS CDMA)
 HW Version: M950.06 x.Q
 SW Version: M950VPLF4
 Maximum Tested Conducted Power (HAC): 25.11 dBm (PCS CDMA)
 Antenna: Internal Antenna
 HAC Test Configurations: PCS CDMA, 25, 600, 1175, BT Off, WLAN Off
 EUT Type: Portable Handset

| Air-Interface | Band (MHz) | Type | C63.19/tested | Simultaneous Transmissions (Not to be tested) | Reduced power 20.19 (c)(1) | Voice Over Digital Transport (Data) |
|---------------|------------|-------|---------------|---|----------------------------|-------------------------------------|
| CDMA | 1900 | Voice | Yes | Yes: BT or WIFI | N/A | N/A |
| | EVDO | Data | N/A | | N/A | Yes |
| BT | 2450 | Data | N/A | Yes: CDMA | N/A | N/A |
| WIFI | 2450 | Data | N/A | Yes: CDMA | N/A | Yes |
| | 5200 | | | | | |
| | 5300 | | | | | |
| | 5500 | | | | | |
| | 5800 | | | | | |

NOTE: HAC Rating was not based on concurrent voice and data modes. Standalone mode was found to represent worst case rating for both M and T rating.

Table 3: A3LSPHM950 Air Interfaces

| | | | | |
|-------------------------------|-------------------------|-------------------------------|--|---------------------------------|
| FCC ID: A3LSPHM950 | PCTEST | HAC (T-COIL) TEST REPORT | | Reviewed by: Quality Manager |
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4. ANSI C63.19-2007 PERFORMANCE CATEGORIES

I. MAGNETIC COUPLING

Axial and Radial Field Intensity

All orientations of the magnetic field, in the axial, horizontal and vertical position along the measurement plane shall be ≥ -18 dB(A/m) at 1 kHz in a 1/3 octave band filter per 7.3.1.

Frequency Response

The frequency response of the axial component of the magnetic field shall follow the response curve specified in EIA RS-504-1983, over the frequency range 300 Hz – 3000 Hz per 7.3.2.

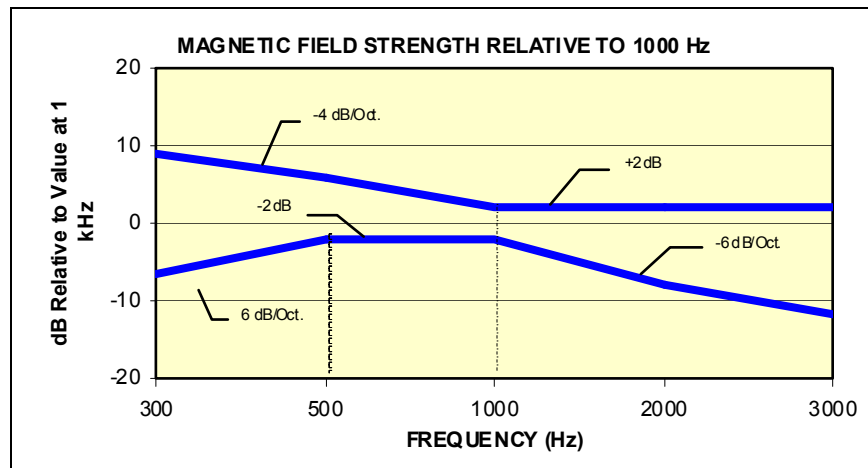


Figure 4-1
Magnetic field frequency response for Wireless Devices with an axial field ≤ -15 dB (A/m) at 1 kHz

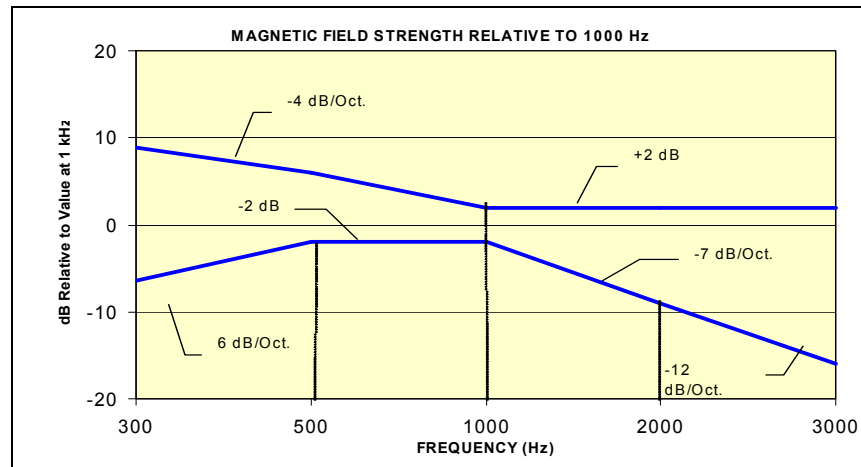


Figure 4-2
Magnetic Field frequency response for wireless devices with an axial field that exceeds -15 dB(A/m) at 1 kHz

| | | | |
|-------------------------------|--|-------------------------------|-------------------------------------|
| FCC ID: A3LSPHM950 | <small>PCTEST ENGINEERING LABORATORY, INC.</small> | HAC (T-COIL) TEST REPORT | Reviewed by: Quality Manager |
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Signal Quality

The table below provides the signal quality requirement for the intended audio magnetic signal from a wireless device. Only the RF immunity of the hearing aid is measured in T-coil mode. It is assumed that a hearing aid can have no immunity to an interference signal in the audio band, which is the intended reception band for this mode. The only criterion that can be measured is the RF immunity in T-coil mode. This is measured using the same procedure as the audio coupling mode at the same levels.

The signal quality of the axial and radial components of the magnetic field was used to determine the T-coil mode category.

| Category | Telephone RF Parameters |
|----------|---|
| | Wireless Device Signal Quality (Signal + Noise-to-noise ratio in dB) |
| T1 | 0 to 10 dB |
| T2 | 10 to 20 dB |
| T3 | 20 to 30 dB |
| T4 | > 30 dB |

Table 4-1
Magnetic Coupling Parameters

| | | | | |
|-------------------------------|--|-------------------------------|---|---------------------------------|
| FCC ID: A3LSPHM950 |  PCTEST Engineering Laboratory, Inc. | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | | Page 7 of 37 |

5. METHOD OF MEASUREMENT

I. Test Setup

The equipment was connected as shown in an acoustic/RF hemi-anechoic chamber:

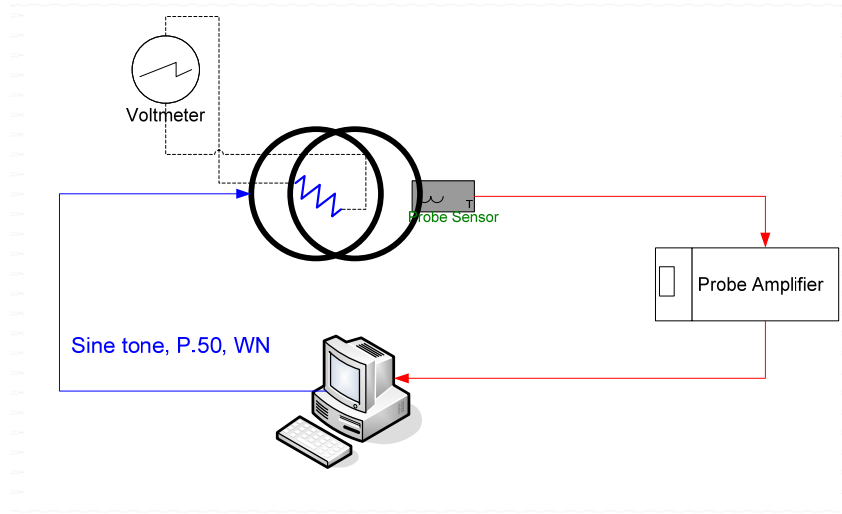


Figure 5-1 Validation Setup with Helmholtz Coil

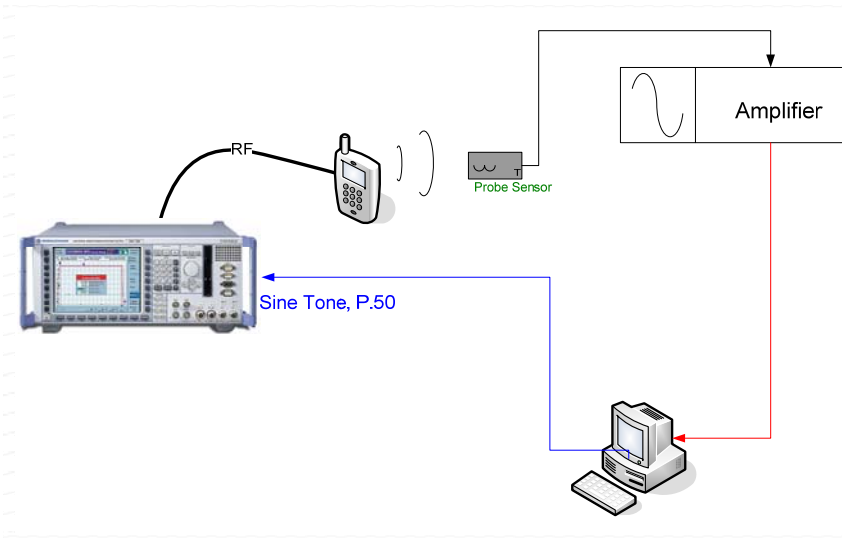




Figure 5-2 T-Coil Test Setup

| | | | | |
|-------------------------------|---|-------------------------------|---|---------------------------------|
| FCC ID: A3LSPHM950 |  | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
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II. Scanning Mechanism

Manufacturer: TEM
 Accuracy: ± 0.83 cm/meter
 Minimum Step Size: 0.1 mm
 Maximum speed: 6.1 cm/sec
 Line Voltage: 115 VAC
 Line Frequency: 60 Hz
 Material Composite: Delrin (Acetal)
 Data Control: Parallel Port
 Dynamic Range (X-Y-Z): 45 x 31.75 x 47 cm
 Dimensions: 36" x 25" x 38"
 Operating Area: 36" x 49" x 55"
 Reflections: < -20 dB (in anechoic chamber)

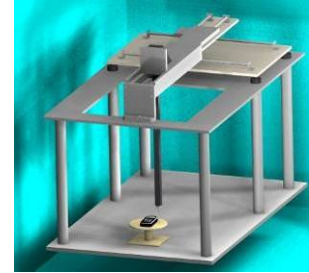


Figure 5-3
RF Near-Field Scanner

III. ITU-T P.50 Artificial Voice

Manufacturer: ITU-T
 Active Frequency Range: 100 Hz – 8 kHz
 Stimulus Type: Male and Female, no spaces
 Single Sample Duration: 20.96 seconds
 Activity Level: 100%

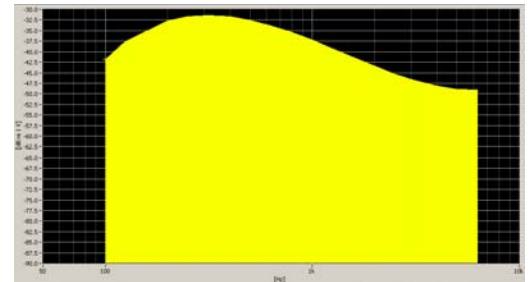


Figure 5-4
Spectral Characteristic of full P.50

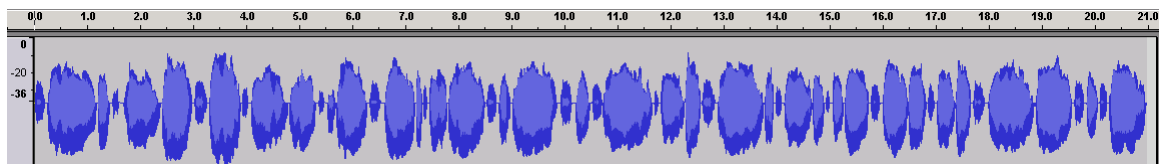


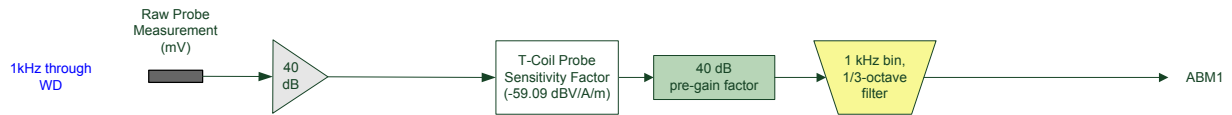


Figure 5-5
Temporal Characteristic of full P.50

| | | | | |
|-------------------------------|---|-------------------------------|---|---------------------------------|
| FCC ID: A3LSPHM950 |  | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
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ABM1 Measurement Block Diagram:



ABM2 Measurement Block Diagram:

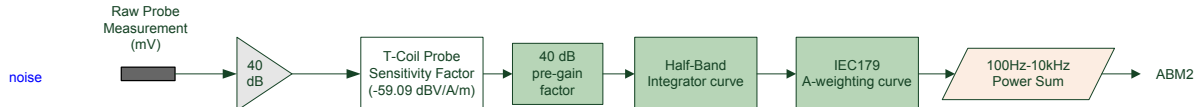


Figure 5-6 Magnetic Measurement Processing Steps

IV. Test Procedure

1. Ambient Noise Check per C63.19 §6.2.1
 - a. Ambient interference was monitored using a Real-Time Analyzer between 100-10,000 Hz with 1/3 octave filtering.
 - b. “A-weighting” and Half-Band Integration was applied to the measurements.
 - c. Since this measurement was measured in the same method as ABM2 measurements, this level was verified to be less than 10 dB below the lowest measurement signal (which is the highest ABM2 measurement for a T4 WD). Therefore the maximum noise level for a T4 WD with an ABM1 = -18 dBA/m is:

$$-18 - 30 - 10 = -58 \text{ dBA/m}$$

2. Measurement System Validation (See Figure 5-1)
 - a. The measurement system including the probe, pre-amplifier and acquisition system were validated as an entire system to ensure the reliability of test measurements.
 - b. ABM1 Validation
 The magnetic field at the center of the Helmholtz coil is given by the equation (per C63.19 Annex D.9.1):



$$H_c = \frac{NI}{r\sqrt{1.25^3}} = \frac{N(\frac{V}{R})}{r\sqrt{1.25^3}}$$

Where H_c = magnetic field strength in amperes per meter
 N = number of turns per coil

For the Helmholtz Coil, N=20; r=0.08m; R=10.193Ω and using V=57mV:

$$H_c = \frac{20 \cdot (\frac{0.057}{10.193})}{0.08 \cdot \sqrt{1.25^3}} = 1.0003 \text{ A/m}$$

Therefore a pure tone of 1kHz was applied into the coils such that 57 mV was observed across the 10 Ω resistor. The voltmeter used for measurement was verified to be capable of measurements in the audio band range. This theoretically generates an expected field of 1 A/m in the center of the Helmholtz coil which was used to validate the probe

| | | | | |
|-------------------------------|---|-------------------------------|---|---------------------------------|
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measurement at 1 A/m. This was verified to be within ± 0.5 dB of the 1 A/m value (see Page 19).

c. Frequency Response Validation

The frequency response through the Helmholtz Coil was verified to be within 0.5 dB relative to 1 kHz, between 300 – 3000 Hz using the ITU-P.50 artificial speech signal as shown below:

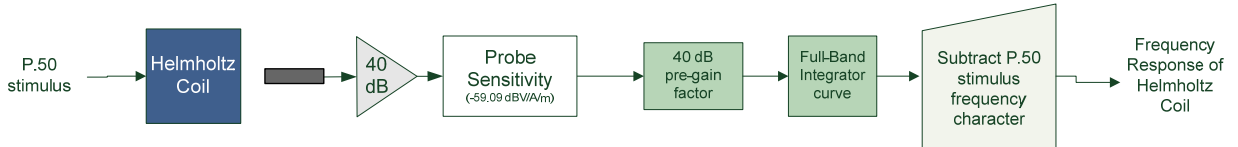


Figure 5-7 Frequency Response Validation

d. ABM2 Measurement Validation

WD noise measurements are filtered with A-weighting and Half-Band Integration over a frequency range of 100Hz – 10kHz to process ABM2 measurements. Below is the verification of the system processing A-weighting and Half-Band integration between system input to output within 0.5 dB of the theoretical result:

**Table 5-1
ABM2 Frequency Response Validation**

| f (Hz) | HBI, A - Measured (dB re 1kHz) | HBI, A - Theoretical (dB re 1kHz) | dB Var. |
|--------|--------------------------------|-----------------------------------|---------|
| 100 | -16.180 | -16.170 | -0.010 |
| 125 | -13.257 | -13.250 | -0.007 |
| 160 | -10.347 | -10.340 | -0.007 |
| 200 | -8.017 | -8.010 | -0.007 |
| 250 | -5.925 | -5.920 | -0.005 |
| 315 | -4.045 | -4.040 | -0.005 |
| 400 | -2.405 | -2.400 | -0.005 |
| 500 | -1.212 | -1.210 | -0.002 |
| 630 | -0.349 | -0.350 | 0.001 |
| 800 | 0.071 | 0.070 | 0.001 |
| 1000 | 0.000 | 0.000 | 0.000 |
| 1250 | -0.503 | -0.500 | -0.003 |
| 1600 | -1.513 | -1.510 | -0.003 |
| 2000 | -2.778 | -2.780 | 0.002 |
| 2500 | -4.316 | -4.320 | 0.004 |
| 3150 | -6.166 | -6.170 | 0.004 |
| 4000 | -8.322 | -8.330 | 0.008 |
| 5000 | -10.573 | -10.590 | 0.017 |
| 6300 | -13.178 | -13.200 | 0.022 |
| 8000 | -16.241 | -16.270 | 0.029 |
| 10000 | -19.495 | -19.520 | 0.025 |

| | | | | |
|-------------------------------|---|-------------------------------|---------|---------------------------------|
| FCC ID: A3LSPHM950 | PCTEST PCTEST ENGINEERING LABORATORY, INC. | HAC (T-COIL) TEST REPORT | SAMSUNG | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | | Page 11 of 37 |

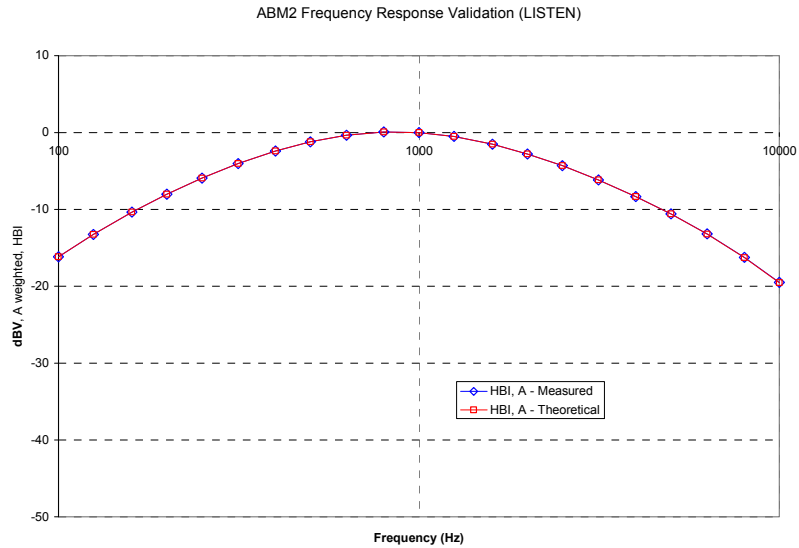


Figure 5-8
ABM2 Frequency Response Validation

The ABM2 result is a power sum from 100 Hz to 10 kHz with half-band integration and A-weighting. To verify the power sum measurement, a power sum over the full band was measured and verified to track with the source level (See Figure 5-9). Therefore the setup in this step was used to verify the power sum post-processing for ABM2 measurements. See below block diagram:

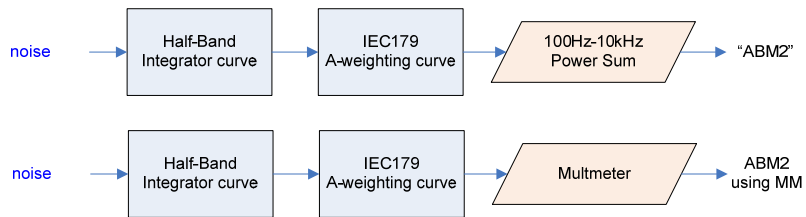


Figure 5-9
ABM2 Validation Block Diagram

The power summed output results for a known input were compared to the multi-meter results to verify any deviation in the post-processing implemented with the power-sum.

Table 5-2
ABM2 Power Sum Validation

| WN Input (dBV) | Power Sum (dBV) | Multimeter-Full (dBV) | Dev (dB) |
|----------------|-----------------|-----------------------|----------|
| -60 | -60.36 | -60.2 | 0.16 |
| -50 | -50.19 | -50.13 | 0.06 |
| -40 | -40.14 | -40.03 | 0.11 |
| -30 | -30.13 | -30.01 | 0.12 |
| -20 | -20.12 | -20 | 0.12 |
| -10 | -10.14 | -10 | 0.14 |

| | | | | |
|-------------------------------|-------------------------|-------------------------------|--|---------------------------------|
| FCC ID: A3LSPHM950 | | HAC (T-COIL) TEST REPORT | | Reviewed by: Quality Manager |
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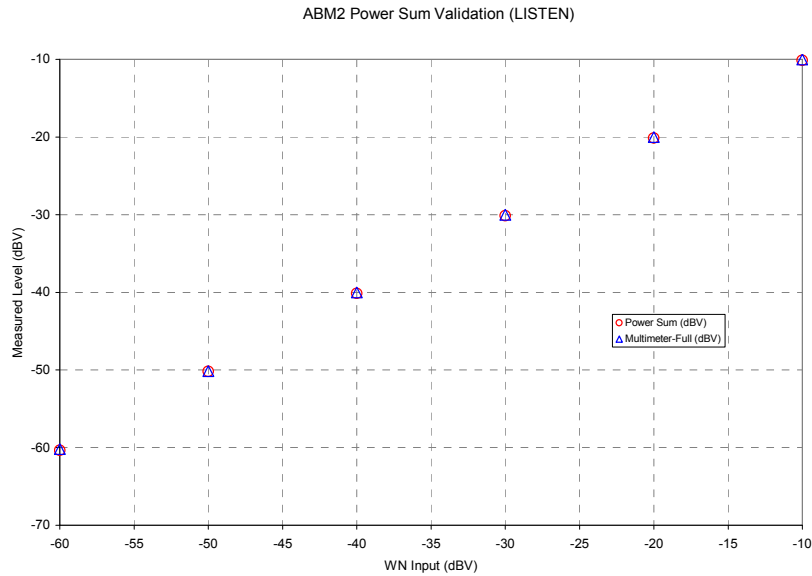


Figure 5-10
ABM2 Power Sum Validation

3. Measurement Test Setup

a. Fine scan above the WD (TEM)

- i. A multitone signal was applied to the handset such that the phone acoustic output was stable within 1dB over the probe settling time and with the acoustic output level at the C63.19 specified levels (below). The measurement step size was in 2 mm increments at a distance of 10 mm between the surface of the wireless device as shown below:

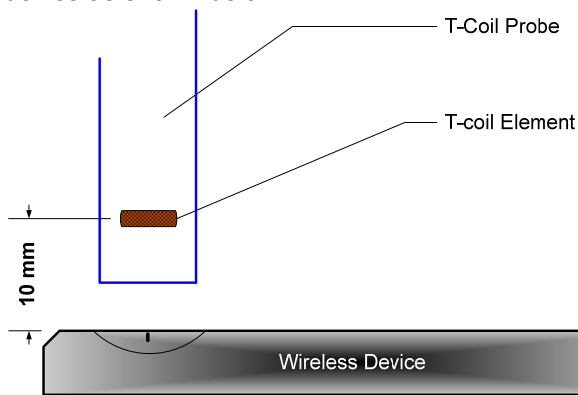


Figure 5-11
Measurement Distance

- ii. After scanning, the planar field maximum point was determined. The position of the probe was moved to this location to setup the test using the sound check system.
- iii. These steps were repeated for the other T-coil orientations (of axial, radial transverse, or radial longitudinal) per Figure 5-16 after a T-coil orientation was fully measured with the sound check system.

| | | | | |
|-------------------------------|-------------------------|-------------------------------|---------------|---------------------------------|
| FCC ID: A3LSPHM950 | | HAC (T-COIL) TEST REPORT | | Reviewed by: Quality Manager |
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- b. Speech Signal Setup to Base Station Simulator
 - i. C63.19 Table 6-1 states audio reference input levels for various technologies:

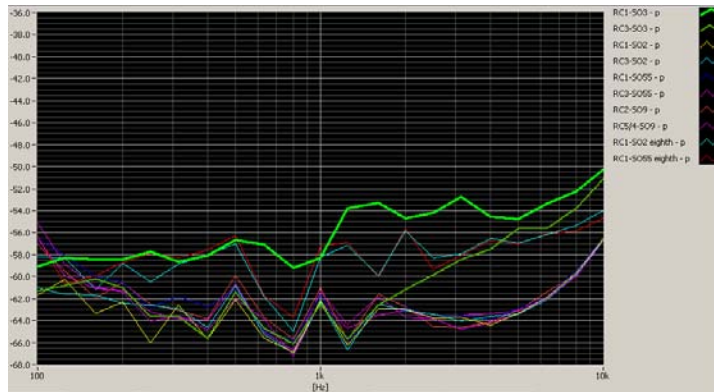
| Standard | Technology | Input Level (dBm0) |
|-----------------|---------------------|--------------------|
| TIA/EIA/IS-2000 | CDMA | -18 |
| J-STD-007 | GSM (217 Hz) | -16 |
| T1/T1P1/3GPP | UMTS (WCDMA) | -16 |
| iDEN™ | TDMA (22 and 11 Hz) | -18 |

The CMU200 audio levels were determined using base station simulator manufacturer calibration procedures resulting in the below corresponding voltages relative to handset test point level (in dBm0):

**Table 5-3
CMU200 Voltage Input Levels for Audio**

| dBm0 Ref. | Input Voltage | | Notes |
|-----------|---------------|-----------|---|
| 3.14 dBm0 | 1052.0 mV | 0.4 dBV | From CDMA2K "DECODER CAL". (What is needed through Encoder for FS) |
| -18 dBm0 | 92.260 mV | -20.7 dBV | For 8k Enhanced (Low) |

- c. Real-Time Analyzer (RTA)
 - i. The Real-Time Analyzer was configured to analyze measurements using 1/3 Octave band weighted filtering.
- d. WD Radio Configuration Selection
 - i. The device was chosen to be tested in the worst-case ABM2 condition under RC1/SO3 (EVRC) (see below):



**Figure 5-12
Vocoder Analysis for ABM Noise**

- 4. Signal Quality Data Analysis
 - a. Narrow-band Magnetic Intensity
 - i. The standard specifies a 1 kHz 1/3 octave band minimum field intensity for a sine tone. The ABM1 measurements were evaluated at 1kHz with 1/3 octave band filtering over an averaged period of 10 seconds.
 - b. Frequency Response
 - i. The appropriate frequency response curve was measured to curves in Figure 4-1 or Figure 4-2 between 300 – 3000 Hz using digital linear averaging (limit lines

| | | | | |
|-------------------------------|--|-------------------------------|---------------|---------------------------------|
| FCC ID: A3LSPHM950 | PCTEST Engineering Laboratory, Inc. | HAC (T-COIL) TEST REPORT | SAMSUNG | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | Page 14 of 37 | |

chosen according to measurement found in step 4a.) A linear average over 3x the length of the artificial voice signal (3x sampling) was performed. A 10 second delay was configured in the measurement process of the stimulus to ensure handset vocoder latency effects and echo cancellation devices (if any) were appropriately stabilized during measurements.

- ii. The appropriate post-processing was applied according to the system processing chain illustrated in Figure 5-13. All R10 frequencies were plotted with respect to 0dB at 1 kHz value and aligned with respect to the EIA-504 mask.

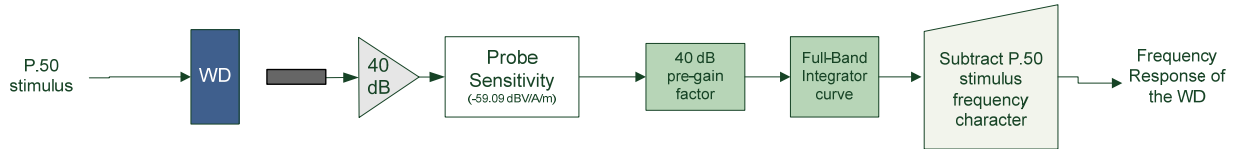


Figure 5-13 Frequency Response Block Diagram

- iii. The margin is represented by the closest measured data point on the curve to the EIA-504 limit lines, in dB.
- c. Signal Quality Index
- i. Ensuring the WD was at maximum RF power, maximum volume, backlight on, display on, maximum contrast setting, keypad lights on (when possible) with no audio signal through the vocoder, the WD was measured over at least 100 Hz – 10,000 Hz, maximized over 5 seconds with a 50ms sample time for the ABM2 measurement (5 second time period is used in noise measurements under standards such as IEEE 269, etc.)
 - ii. After applying half-band integration and A-weighting to the result, a power sum was applied over each 1/3 octave bandwidth frequency for an ABM2 value
 - iii. This result was subtracted from the ABM1 result in step a, to obtain the Signal Quality.

V. Test Setup

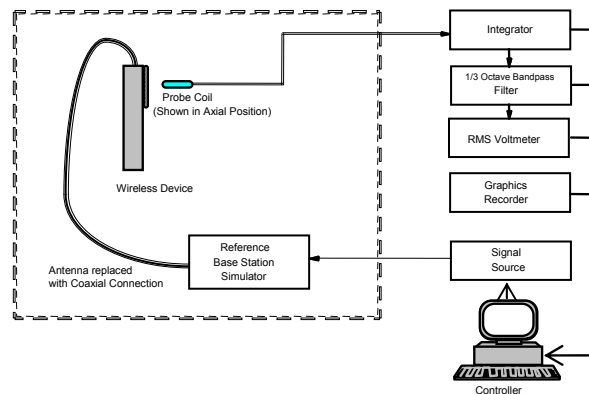




Figure 5-14 Audio Magnetic Field Test Setup

VI. Deviation from C63.19 Test Procedure

Non-conducted RF connection.

| | | | | |
|-------------------------------|---|-------------------------------|---|---------------------------------|
| FCC ID: A3LSPHM950 |  | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | | Page 15 of 37 |

VII. Wireless Device Channels and Frequencies

The frequencies listed in the table below are those that lie in the center of the bands used for cellular telephony. Low, middle and high channels were tested in each band for FCC compliance evaluation to ensure the maximum emission is captured across the entire band.

To facilitate setting of a base station simulator for ABM measurements, specific band plan channel numbers are listed that may be used in lieu of the band center frequencies.

**Table 5-4
Center Channels and Frequencies**

| Test frequencies & associated channels | |
|--|-----------------|
| Channel | Frequency (MHz) |
| Cellular 850 | |
| 384 (CDMA) | 836.52 |
| 4183(WCDMA) | 836.60 |
| 190 (GSM) | 836.60 |
| PCS 1900 | |
| 661 (GSM) | 1880 |
| 600 (CDMA) | 1880 |
| 9400 (WCDMA) | 1880 |
| AWS 1750 | |
| 450 (CDMA) | 1732.50 |
| 1412 (WCDMA) | 1730.40 |

VIII. RF Emission Effect on T-coil Measurements

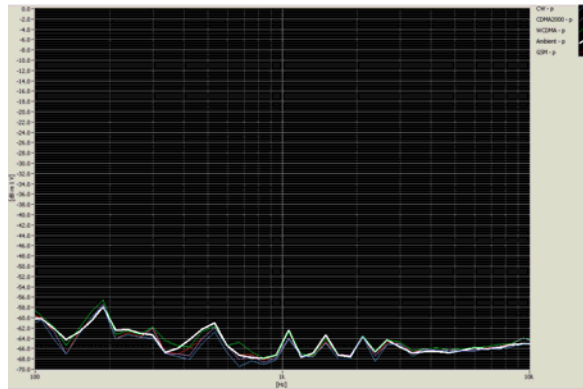




Figure 5-15

High power RF Emissions Effect with HAC Dipole on the T-coil Probe System 10mm between dipole maximum and magnetic probe

| | | | | |
|-------------------------------|---|-------------------------------|---|---------------------------------|
| FCC ID: A3LSPHM950 |  PCTEST PCTEST ENGINEERING LABORATORY, INC. | HAC (T-COIL) TEST REPORT |  SAMSUNG | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | | Page 16 of 37 |

IX. Test Flow

The flow diagram below was followed (From C63.19):

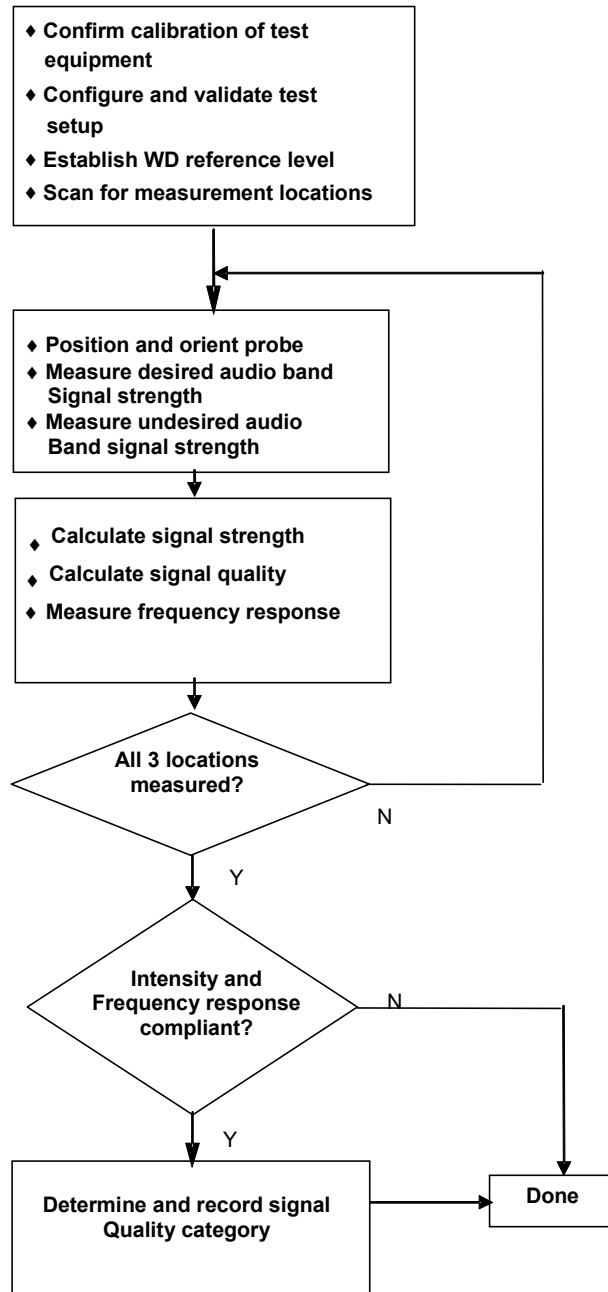




Figure 5-16
C63.19 T-Coil Signal Test Process

| | | | | |
|-------------------------------|---|-------------------------------|---|---------------------------------|
| FCC ID: A3LSPHM950 |  | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | | Page 17 of 37 |

6. TEST SUMMARY

I. T-Coil Test Summary

**Table 6-1
Table of Results**



| C63.19 Sec. | Mode | Band | Test Description | Minimum Limit* | Measured | Verdict |
|-------------|------|------|--------------------------------|----------------|--------------|------------------|
| | | | | <i>dBA/m</i> | <i>dBA/m</i> | <i>PASS/FAIL</i> |
| 7.3.1.1 | CDMA | PCS | Intensity, Axial | -18 | 3.2 | PASS |
| 7.3.1.2 | | | Intensity, RadialH | -18 | -5.8 | PASS |
| 7.3.1.2 | | | Intensity, RadialV | -18 | -5.1 | PASS |
| 7.3.3 | | | Signal-to-Noise/Noise, Axial | 20 | 42.5 | PASS |
| 7.3.3 | | | Signal-to-Noise/Noise, RadialH | 20 | 38.5 | PASS |
| 7.3.3 | | | Signal-to-Noise/Noise, RadialV | 20 | 31.4 | PASS |
| 7.3.2 | | | Frequency Response, Axial | 0 | 1.4 | PASS |

Note: The above summary table represents the worst-case numerical values according to configurations in Table 6-3.

**Table 6-2
Consolidated Tabled Results**

| | Volume Setting | PCS | | |
|----------------------------|----------------|-------|---------|---------|
| | | Axial | RadialH | RadialV |
| Freq. Response Margin | Maximum | PASS | PASS | PASS |
| Magnetic Intensity Verdict | | PASS | PASS | PASS |
| FCC SNR Verdict | | PASS | PASS | PASS |

Note: The above table represents the pass/fail verdict according to data in Table 6-3.

| | | | | |
|-------------------------------|--|-------------------------------|---|---------------------------------|
| FCC ID: A3LSPHM950 |  PCTEST Engineering Laboratory, Inc. | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | | Page 18 of 37 |

II. Raw Handset Data

**Table 6-3
Raw Data Results**

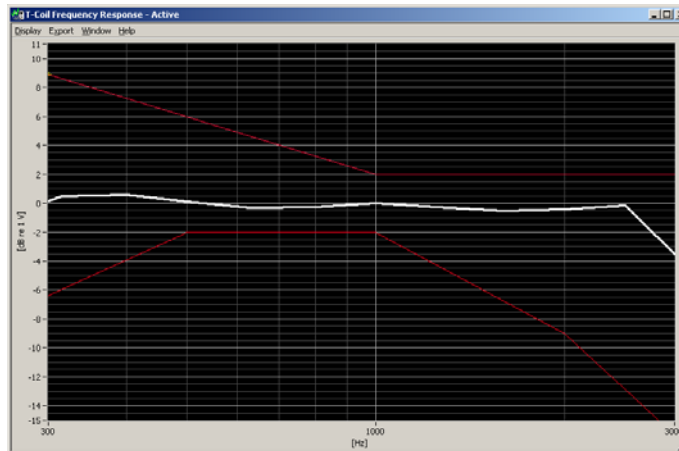
| | Volume | PCS Band | | | | | | | | |
|----------------------------|------------------------|----------|--------|--------|---------|--------|--------|---------|--------|--------|
| | | Axial | | | RadialH | | | RadialV | | |
| | | 25 | 600 | 1175 | 25 | 600 | 1175 | 25 | 600 | 1175 |
| ABM1, dBA/m | Maximum | 3.22 | 3.55 | 3.35 | -5.19 | -5.81 | -5.74 | -5.05 | -4.97 | -4.98 |
| ABM2, dBA/m | | -39.30 | -39.11 | -40.75 | -43.95 | -44.28 | -44.29 | -36.56 | -36.36 | -38.07 |
| Ambient Noise, dBA/m | | -61.86 | -61.86 | -61.86 | -62.49 | -62.49 | -62.49 | -61.78 | -61.78 | -61.78 |
| Freq. Response Margin (dB) | | 1.67 | 1.85 | 1.41 | 1.51 | 1.54 | 1.81 | 1.48 | 1.42 | 1.62 |
| S+N/N (dB) | | 42.52 | 42.66 | 44.10 | 38.76 | 38.47 | 38.55 | 31.51 | 31.39 | 33.09 |
| S+N/N per orientation (dB) | | 42.52 | | | 38.47 | | | 31.39 | | |
| T-coil Coordinates (cm) | [x,y] from bottom left | 2.7,2.8 | | | 2.6,3.6 | | | 3.4,2.7 | | |

Note: ABM1 >> Ambient noise

WD Configuration



1. Radio Configuration: RC1/SO3 (EVRC)
2. Power Configuration: Power Control Bits = "All Up"
3. Phone Condition: Mute on; Backlight on; Max Volume, Max Contrast

III. Frequency Response Graph

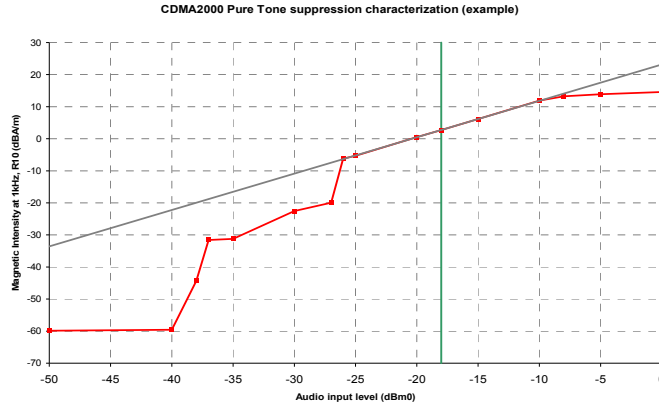


**Figure 6-1
Axial Frequency Response**

Note: This frequency response represents the worst-case ABM2 test configuration according to Table 6-3.

| | | | | |
|-------------------------------|---|-------------------------------|---|---------------------------------|
| FCC ID: A3LSPHM950 |  | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | Page 19 of 37 | |

IV. 1 kHz Vocoder Application Check



This model was verified to be within the linear region for ABM1 measurements. This measurement was taken in the axial configuration above the ABM1 maximum location/configuration derived from Table 6-3.

V. Undesirable Audio Magnetic Band Plot (ABM2)

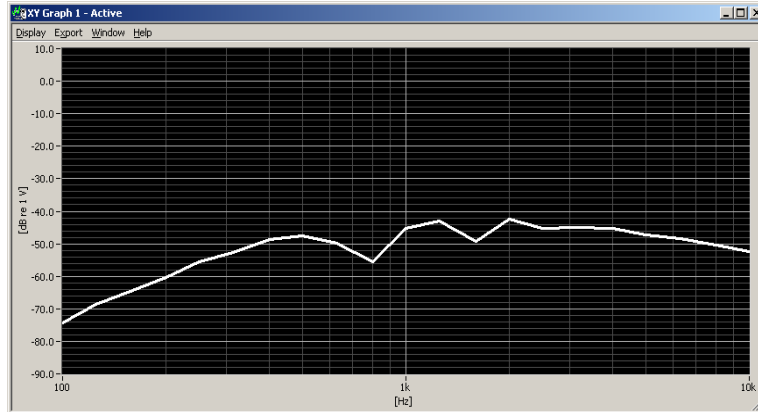




Figure 6-2
Worst-case ABM2 Plot for WD

Note: This plot represents the data from the location/configuration resulting in the highest ABM2 result shown in Table 6-3.

| | | | | |
|-------------------------------|---|-------------------------------|---|---------------------------------|
| FCC ID: A3LSPHM950 |  | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | Page 20 of 37 | |

VI. T-Coil Validation Test Results

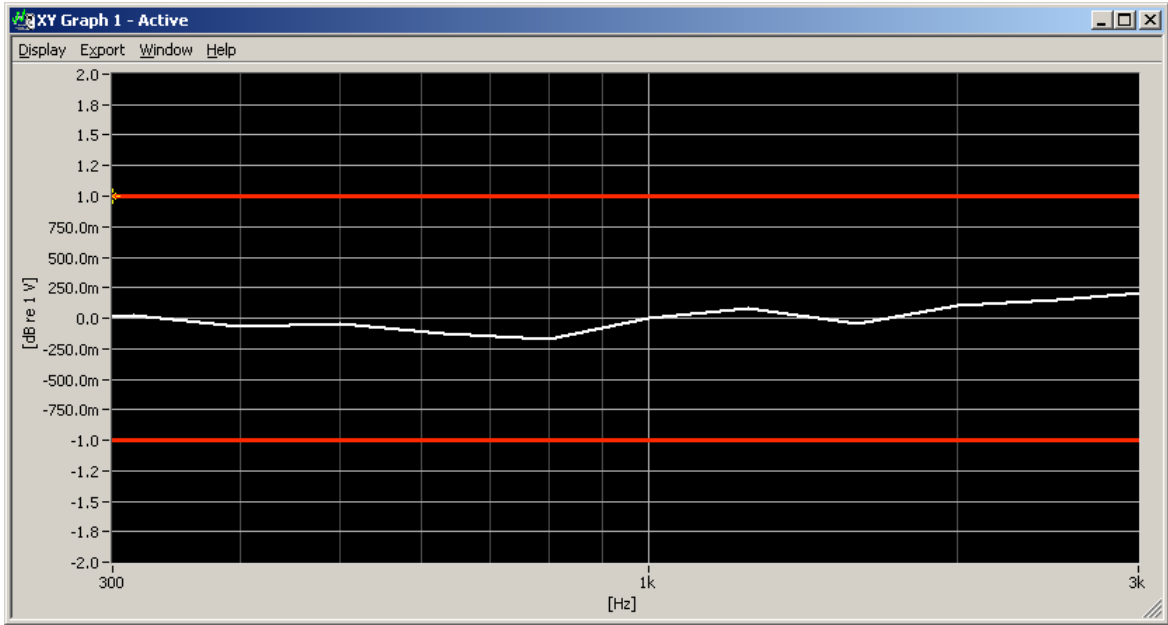




Figure 6-3
Helmholtz Coil Validation for Frequency Response

Table 6-4
Helmholtz Coil Validation Table of Results

| Item | Target | Result | Verdict |
|---------------------------------|--------------------------|--------|---------|
| Signal Validation | | | |
| Frequency Response, from limits | $0 \pm 0.5 \text{ dB}$ | 0.20 | PASS |
| Magnetic Intensity, -10 dBA/m | $-10 \pm 0.5 \text{ dB}$ | -9.782 | PASS |
| Noise Validation | | | |
| Axial Environmental Noise | < - 58 dBA/m | -61.86 | PASS |
| RadialH Environmental Noise | < - 58 dBA/m | -62.49 | PASS |
| RadialV Environmental Noise | < - 58 dBA/m | -61.78 | PASS |

| | | | | |
|-------------------------------|---|-------------------------------|---|---------------------------------|
| FCC ID: A3LSPHM950 |  | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | | Page 21 of 37 |

7. FCC 3G MEASUREMENTS

Radio Configuration 1, Service Option 3 (thick, green data curve) was used for the testing as the worst-case configuration for the handset due to vocoder gating from the EVRC logic. See below plot for ABM noise comparison between operational field service options and radio configurations for a CDMA2000 handset:

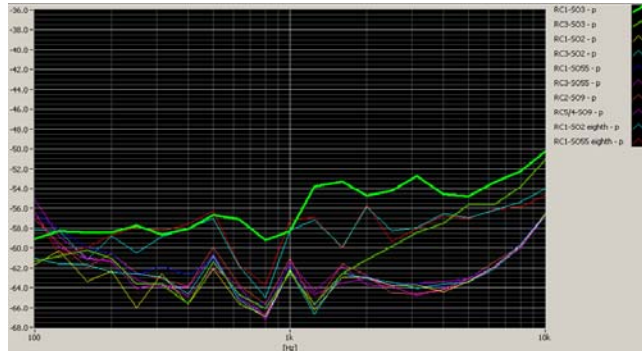


Figure 7-1
CDMA2000 Audio Band Magnetic Noise

I. ABM Measurements

ABM2 Pre-Test (dBA/m), A, HBI

| RC1/SO3 | RC3/SO3 | RC4/SO3 | Orientation | Channel |
|---------|---------|---------|-------------|---------|
| -36.83 | -57.40 | -57.04 | RadV | 600 |

ABM1 Pre-Test (dBA/m)

| RC1/SO3 | RC3/SO3 | RC4/SO3 | Orientation | Channel |
|---------|---------|---------|-------------|---------|
| -4.270 | -5.430 | -4.860 | RadV | 600 |

- Mute on; Backlight on; Max Volume, Max Contrast
- Power Control Bits = "All Up"



Figure 7-2
Audio Band Magnetic Curve Measurement Block Diagram

| | | | | |
|-------------------------------|---|-------------------------------|---------|---------------------------------|
| FCC ID: A3LSPHM950 | PCTEST PCTEST ENGINEERING LABORATORY, INC. | HAC (T-COIL) TEST REPORT | SAMSUNG | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | | Page 22 of 37 |

8. MEASUREMENT UNCERTAINTY



**Table 8-1
Uncertainty Estimation Table**

| Contribution | Data +/- % | Data +/- dB | Data Type | Probability distribution | Divisor | Standard uncertainty | Standard Uncertainty (dB) |
|--|------------|-------------|---------------|--------------------------|---------|----------------------|---------------------------|
| ABM Noise | 7.0% | 0.29 | Std. Dev. | Normal k=1 | 1.00 | 7.0% | |
| RF Reflections | 4.7% | 0.20 | Specification | Rectangular | 1.73 | 2.7% | |
| Reference Signal Level | 12.2% | 0.50 | Specification | Rectangular | 1.73 | 7.0% | |
| Positioning Accuracy | 10.0% | 0.41 | Uncertainty | Rectangular | 1.73 | 5.8% | |
| Probe Coil Sensitivity | 12.2% | 0.50 | Specification | Rectangular | 1.73 | 7.0% | |
| Probe Linearity | 2.4% | 0.10 | Std. Dev. | Normal k=1 | 1.00 | 2.4% | |
| Cable Loss | 2.8% | 0.12 | Specification | Rectangular | 1.73 | 1.6% | |
| Frequency Analyzer | 5.0% | 0.21 | Specification | Rectangular | 1.73 | 2.9% | |
| System Repeatability | 5.0% | 0.21 | Std. Dev. | Normal k=1 | 1.00 | 5.0% | |
| WD Repeatability | 9.0% | 0.37 | Std. Dev. | Normal k=1 | 1.00 | 9.0% | |
| Positioner Accuracy | 1.0% | 0.04 | Specification | Rectangular | 1.73 | 0.6% | |
| Combined standard uncertainty, uc (k=1) | | | | | | 17.7% | 0.71 |
| Expanded uncertainty (k=2), 95% confidence level | | | | | | 35.3% | 1.31 |

Notes:

1. Test equipments are calibrated according to techniques outlined in NIS81, NIS3003 and NIST Tech Note 1297.
2. All equipments have traceability according to NIST. Measurement Uncertainties are defined in further detail in NIS 81 and NIST Tech Note 1297 and UKAS M3003.



Measurement uncertainty reflects the quality and accuracy of a measured result as compared to the true value. Such statements are generally required when stating results of measurements so that it is clear to the intended audience that the results may differ when reproduced by different facilities. Measurement results vary due to the measurement uncertainty of the instrumentation, measurement technique, and test engineer. Most uncertainties are calculated using the tolerances of the instrumentation used in the measurement, the measurement setup variability, and the technique used in performing the test. While not generally included, the variability of the equipment under test also figures into the overall measurement uncertainty. Another component of the overall uncertainty is based on the variability of repeated measurements (so-called Type A uncertainty). This may mean that the Hearing Aid compatibility tests may have to be repeated by taking down the test setup and resetting it up so that there are a statistically significant number of repeat measurements to identify the measurement uncertainty. By combining the repeat measurement results with that of the instrumentation chain using the technique contained in NIS 81 and NIS 3003, the overall measurement uncertainty was estimated.

| | | | | |
|--------------------------------------|---|--------------------------------------|---|--|
| FCC ID: A3LSPHM950 |  | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | Page 23 of 37 | |



9. EQUIPMENT LIST

**Table 9-1
Equipment List**

| Manufacturer | Model | Description | Cal Date | Cal Interval | Cal Due | Serial Number |
|-----------------|---------------------|-------------------------------------|------------|--------------|------------|---------------|
| Agilent | E4407B | ESA Spectrum Analyzer | 4/3/2012 | Annual | 4/3/2013 | US39210313 |
| Agilent | E5515C | Wireless Communications Test Set | 2/14/2012 | Annual | 2/14/2013 | GB43304447 |
| Agilent | E5515C | Wireless Communications Tester | 4/4/2012 | Annual | 4/4/2013 | US41140256 |
| Control Company | 36934-158 | Wall-Mounted Thermometer | 1/4/2012 | Biennial | 1/4/2014 | 122014497 |
| Control Company | 36934-158 | Wall-Mounted Thermometer | 1/4/2012 | Biennial | 1/4/2014 | 122014488 |
| Gigatronics | 80701A | (0.05-18GHz) Power Sensor | 10/12/2011 | Annual | 10/12/2012 | 1833460 |
| Gigatronics | 8651A | Universal Power Meter | 10/12/2011 | Annual | 10/12/2012 | 8650319 |
| Listen | SoundCheck | Acoustic Analyzer System | 8/23/2011 | Annual | 8/23/2012 | 40603797 |
| Listen | Soundconnect | Microphone Power Supply | 7/13/2011 | Annual | 7/13/2012 | PS1435 |
| NI | 4474 | Data Acquisition Card | N/A | | N/A | N/A |
| Rohde & Schwarz | CMU200 | Base Station Simulator | 5/22/2012 | Annual | 5/22/2013 | 109892 |
| Seekonk | NC-100 | Torque Wrench (8" lb) | 11/29/2011 | Triennial | 11/29/2014 | 21053 |
| TEM | Axial T-Coil Probe | Axial T-Coil Probe | 1/20/2012 | Annual | 1/20/2013 | TEM-1124 |
| TEM | Axial T-Coil Probe | Axial T-Coil Probe | 3/14/2012 | Annual | 3/14/2013 | TEM-1139 |
| TEM | | HAC Positioner | N/A | | N/A | N/A |
| TEM | | HAC System Controller with Software | N/A | | N/A | N/A |
| TEM | C63.19 | Helmholtz Coil | 11/11/2011 | Biennial | 11/11/2013 | 925 |
| TEM | Radial T-Coil Probe | Radial T-Coil Probe | 1/20/2012 | Annual | 1/20/2013 | TEM-1130 |
| TEM | Radial T-Coil Probe | Radial T-Coil Probe | 3/14/2012 | Annual | 3/14/2013 | TEM-1133 |

| | | | | |
|-------------------------------|--|-------------------------------|---|---------------------------------|
| FCC ID: A3LSPHM950 |  PCTEST FIELD SERVICE AND CONSULTING, INC. | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | | Page 24 of 37 |

10. CALIBRATION CERTIFICATES

| | | | | |
|--------------------------------------|---|--------------------------------------|---|--|
| FCC ID: A3LSPHM950 |  | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | Page 25 of 37 | |

West Caldwell Calibration Laboratories Inc.

Certificate of Calibration

for

Axial T Coil Probe

Manufactured by: TEM CONSULTING
Model No: Axial T Coil Probe
Serial No: TEM-1124
Calibration Recall No: 21559

Submitted By:

Customer: STEVE LIU
Company: PCTEST ENGINEERING LAB
Address: 6660-B DOBBIN ROAD
COLUMBIA MD 21045

The subject instrument was calibrated to the indicated specification using standards traceable to the National Institute of Standards and Technology or to accepted values of natural physical constants. This document certifies that the instrument met the following specification upon its return to the submitter.

West Caldwell Calibration Laboratories Procedure No. Axial T Coi TEM

Upon receipt for Calibration, the instrument was found to be:

Within (X) see attached Report of Calibration.

the tolerance of the indicated specification.

West Caldwell Calibration Laboratories' calibration control system meets the requirements, ISO 10012-1 MIL-STD-45662A, ANSI/NCSL Z540-1, IEC Guide 25, ISO 9001:2008 and ISO 17025.

Note: With this Certificate, Report of Calibration is Included.

Approved by:

Calibration Date: 20-Jan-12

6/2
8/27/12

fc

Certificate No: 21559 - 1

Felix Christopher
Quality Manager

QA Doc. #1051 Rev. 2.0 10/1/01



Certificate Page 1 of 1

West Caldwell Calibration Laboratories, Inc.
uncompromised calibration
1575 State Route 96, Victor, NY 14564, U.S.A.

ISO 9001:2008
Registered Company
Cal'bration Traceable
To N. I. S. T.



Phone: (585) 586-3900 Fax.: (585) 586-4327

| | | | | |
|-------------------------------|---|-------------------------------|---|---------------------------------|
| FCC ID: A3LSPHM950 |  | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | | Page 26 of 37 |

REPORT OF CALIBRATION

TEM Consulting LP Axial T Coil Probe for Model No.: Axial T Coil Probe Serial No.: TEM-1124
 Company : Pctest Engineering Lab. I. D. No: 80578

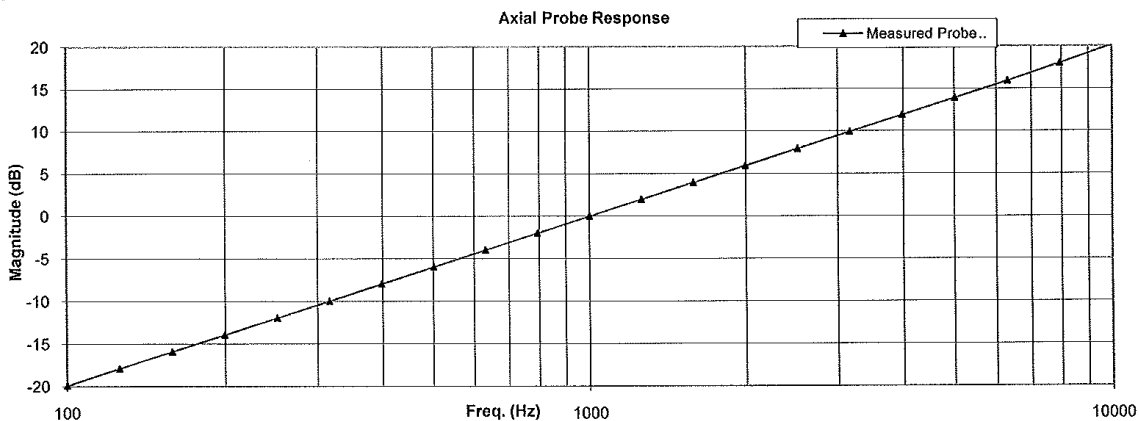
| | | | |
|---|--------|--|-------------------|
| Calibration results: | | Before data: | After data: |
| Probe Sensitivity measured with Helmholtz Coil | | Before & after data same: ...X..... | |
| <i>Helmholtz Coil;</i> | | | |
| the number of turns on each coil; | 10 | No. | |
| the radius of each coil, in meters; | 0.204 | m | |
| the current in the coils, in amperes.; | 0.08 | A | |
| <i>Helmholtz Coil Constant;</i> | | | |
| | 6.98 | A/m/V | |
| <i>Helmholtz Coil magnetic field;</i> | | | |
| | 5.90 | A/m | |
| Laboratory Environment: | | | |
| | | Ambient Temperature: | 22.1 °C |
| | | Ambient Humidity: | 30.8 % RH |
| | | Ambient Pressure: | 100.1 kPa |
| | | Calibration Date: | 20-Jan-12 1:01 PM |
| | | Re-calibration Due: | 20-Jan-13 |
| | | Report Number: | 21559 -1 |
| | | Control Number: | 21559 |
| Probe Sensitivity at | 1000 | Hz. | |
| was | -60.16 | dBV/A/m | |
| | 0.981 | mV/A/m | |
| Probe resistance | 904 | Ohms | |

The above listed instrument meets or exceeds the tested manufacturer's specifications.

This Calibration is traceable through NIST test numbers: ,205342

The expanded uncertainty of calibration: 0.30dB at 95% confidence level with a coverage factor of k=2.

Graph represents Probes Frequency Response.





The above listed instrument was checked using calibration procedure documented in West Caldwell Calibration Laboratories Inc. procedure : **Rev. 5.0 Sept. 10, 2010 Doc. # 1038 HCATEMC**
 Calibration was performed by West Caldwell Calibration Laboratories Inc. under Operating Procedures intended to implement the requirements of ISO10012-1, IEC Guide 25, ANSI/NCSL Z540-1, (MIL-STD-45662A) and ISO 9001:2008, ISO 17025

Cal. Date: 20-Jan-2012 1:01 PM
 Calibrated on WCCL system type 9700

Measurements performed by:
Felix Christopher

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Rev. 5.0 Sept. 10, 2010 Doc. # 1038 HCATEMC

| | | | | |
|-------------------------------|---|-------------------------------|---|---------------------------------|
| FCC ID: A3LSPHM950 |  | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | | Page 27 of 37 |

HCATEMC_TEM-1124_Jan-20-2012

West Caldwell Calibration Laboratories Inc.

1575 State Route 96, Victor NY 14564
Tel. (585) 586-3900 FAX (585) 586-4327

Calibration Data Record

TEM Consulting LP Axial T Coil Probe for Model No.: Axial T Coil Probe Serial No.: TEM-1124

Company : Pctest Engineering Lab.

| Test | Function | Tolerance | Measured values | | | |
|-------|--------------------------|-----------------------|-----------------|-----|---------|--|
| | | | Before | Out | Remarks | |
| 1.0 | Probe Sensitivity at | 1000 Hz. dBV/A/m | -60.16 | | | |
| 2.0 | Probe Level Linearity | dB | | | | |
| | | 6 | 6.03 | | | |
| | | 0 | 0.00 | | | |
| | | -6 | -6.02 | | | |
| | | Ref. (0 dB) | | | | |
| | | -12 | -12.03 | | | |
| 3.0 | Probe Frequency Response | Hz | | | | |
| | | 100 | -19.9 | | | |
| | | 126 | -17.9 | | | |
| | | 158 | -15.9 | | | |
| | | 200 | -13.9 | | | |
| | | 251 | -11.9 | | | |
| | | 316 | -10.0 | | | |
| | | 398 | -8.0 | | | |
| | | 501 | -6.0 | | | |
| | | 631 | -4.0 | | | |
| | | 794 | -2.0 | | | |
| | | | Ref. (0 dB) | | | |
| | | 1000 | 0.0 | | | |
| | | 1259 | 2.0 | | | |
| | | 1585 | 4.0 | | | |
| | | 1995 | 6.0 | | | |
| | | 2512 | 7.9 | | | |
| 3162 | 9.9 | | | | | |
| 3981 | 11.9 | | | | | |
| 5012 | 13.9 | | | | | |
| 6310 | 15.9 | | | | | |
| 7943 | 18.0 | | | | | |
| 10000 | 20.2 | | | | | |



| Instruments used for calibration: | | | Date of Cal. | Traceability No. | Due Date |
|-----------------------------------|--------|--------------|--------------|------------------|-------------|
| HP | 34401A | S/N US360641 | 17-Oct-2011 | ,205342 | 16-Oct-2012 |
| HP | 34401A | S/N US361024 | 17-Oct-2011 | ,205342 | 16-Oct-2012 |
| HP | 33120A | S/N S3604371 | 17-Oct-2011 | ,205342 | 16-Oct-2012 |
| B&K | 2133 | S/N 1492410 | 4-Nov-2011 | 681/280411-11 | 4-Nov-2012 |

Cal. Date: 20-Jan-2012 1:01 PM
Calibrated on WCCL system type 9700

Tested by: Felix Christopher

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Rev. 5.0 Sept. 10, 2010 Doc. # 1038 HCATEMC

| | | | | |
|-------------------------------|---|-------------------------------|---|---------------------------------|
| FCC ID: A3LSPHM950 |  | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | | Page 28 of 37 |

West Caldwell Calibration Laboratories Inc.

Certificate of Calibration

for

Radial T Coil Probe

Manufactured by: TEM CONSULTING
Model No: Radial T Coil Probe
Serial No: TEM-1130
Calibration Recall No: 21559

Submitted By:

Customer: STEVE LIU
Company: PCTEST ENGINEERING LAB
Address: 6660-B DOBBIN ROAD
COLUMBIA MD 21045

The subject instrument was calibrated to the indicated specification using standards traceable to the National Institute of Standards and Technology or to accepted values of natural physical constants. This document certifies that the instrument met the following specification upon its return to the submitter.

West Caldwell Calibration Laboratories Procedure No. Radial T C TEM

Upon receipt for Calibration, the instrument was found to be:

Within (X) see attached Report of Calibration.

the tolerance of the indicated specification.

West Caldwell Calibration Laboratories' calibration control system meets the requirements, ISO 10012-1 MIL-STD-45662A, ANSI/NCSL Z540-1, IEC Guide 25, ISO 9001:2008 and ISO 17025.

Note: With this Certificate, Report of Calibration is included.

Approved by:

Calibration Date: 20-Jan-12

ok ✓ sv 1/20/12

FC

Certificate No: 21559 - 2

Felix Christopher
Quality Manager

QA Doc. #1051 Rev. 2.0 10/1/01



Certificate Page 1 of 1

West Caldwell Calibration Laboratories, Inc.
uncompromised calibration
1575 State Route 96, Victor, NY 14564, U.S.A.

ISO 9001:2008
Registered Company
Calibration Traceable
To N. I. S. T.



Phone: (585) 586-3900 Fax.: (585) 586-4327

| | | | | |
|-------------------------------|---|-------------------------------|---|---------------------------------|
| FCC ID: A3LSPHM950 |  | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | | Page 29 of 37 |

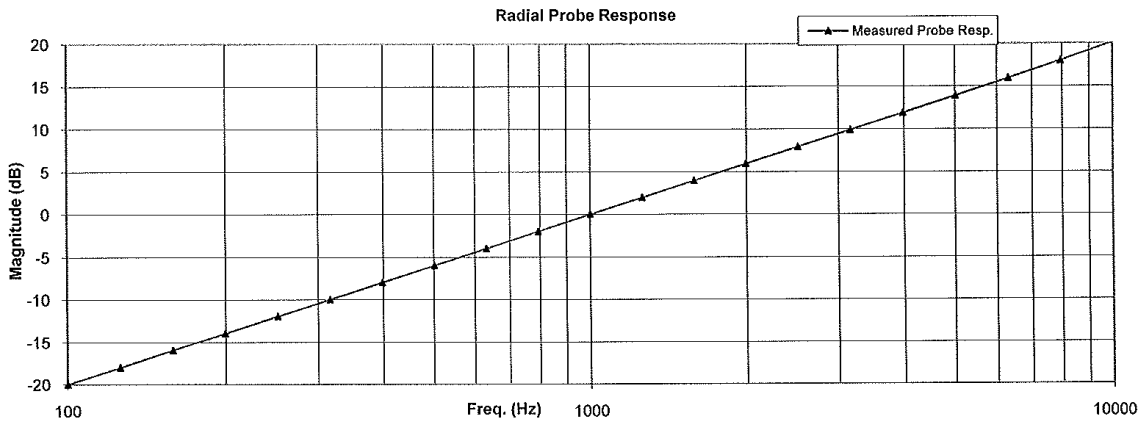
REPORT OF CALIBRATION

for
TEM Consulting LP Radial T Coil Probe **Model No.: Radial T Coil Probe** **Serial No.: TEM-1130**
Company : Pctest Engineering Lab. **I. D. No: 80579**

| | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
|---|-----------------------------------|----|---------|-----|-------------------------------------|-------|--|---|--|------|--|---|---------------------------------|------|--|-------|---------------------------------------|------|--|-----|----------------------|------|--|-----|-----|--------|--|---------|--|-------|--|--------|------------------|-----|--|------|---|----------------------|------|--|----|-------------------|------|--|------|-------------------|-------|--|-----|-------------------|-----------|--|---------|---------------------|-----------|--|--|----------------|-------|--|----|-----------------|-------|--|--|
| <p>Calibration results:</p> <p style="text-align: center;">Probe Sensitivity measured with Helmholtz Coil</p> <p style="text-align: center;"><i>Helmholtz Coil;</i></p> <table style="width: 100%;"> <tr> <td style="width: 30%;">the number of turns on each coil;</td> <td style="width: 10%; text-align: center;">10</td> <td style="width: 10%;"></td> <td style="width: 10%; text-align: center;">No.</td> </tr> <tr> <td>the radius of each coil, in meters;</td> <td style="text-align: center;">0.204</td> <td></td> <td style="text-align: center;">m</td> </tr> <tr> <td>the current in the coils, in amperes.;</td> <td style="text-align: center;">0.08</td> <td></td> <td style="text-align: center;">A</td> </tr> <tr> <td><i>Helmholtz Coil Constant;</i></td> <td style="text-align: center;">6.98</td> <td></td> <td style="text-align: center;">A/m/V</td> </tr> <tr> <td><i>Helmholtz Coil magnetic field;</i></td> <td style="text-align: center;">5.90</td> <td></td> <td style="text-align: center;">A/m</td> </tr> </table> <table style="width: 100%;"> <tr> <td style="width: 30%;">Probe Sensitivity at</td> <td style="width: 10%; text-align: center;">1000</td> <td style="width: 10%;"></td> <td style="width: 10%; text-align: center;">Hz.</td> </tr> <tr> <td>was</td> <td style="text-align: center;">-60.50</td> <td></td> <td style="text-align: center;">dBV/A/m</td> </tr> <tr> <td></td> <td style="text-align: center;">0.944</td> <td></td> <td style="text-align: center;">mV/A/m</td> </tr> <tr> <td>Probe resistance</td> <td style="text-align: center;">903</td> <td></td> <td style="text-align: center;">Ohms</td> </tr> </table> | the number of turns on each coil; | 10 | | No. | the radius of each coil, in meters; | 0.204 | | m | the current in the coils, in amperes.; | 0.08 | | A | <i>Helmholtz Coil Constant;</i> | 6.98 | | A/m/V | <i>Helmholtz Coil magnetic field;</i> | 5.90 | | A/m | Probe Sensitivity at | 1000 | | Hz. | was | -60.50 | | dBV/A/m | | 0.944 | | mV/A/m | Probe resistance | 903 | | Ohms | <p>Before data: After data:</p> <p style="text-align: center;">Before & after data same: ...X.....</p> <p>Laboratory Environment:</p> <table style="width: 100%;"> <tr> <td style="width: 60%;">Ambient Temperature:</td> <td style="width: 10%; text-align: center;">22.1</td> <td style="width: 10%;"></td> <td style="width: 10%; text-align: center;">°C</td> </tr> <tr> <td>Ambient Humidity:</td> <td style="text-align: center;">30.8</td> <td></td> <td style="text-align: center;">% RH</td> </tr> <tr> <td>Ambient Pressure:</td> <td style="text-align: center;">100.1</td> <td></td> <td style="text-align: center;">kPa</td> </tr> <tr> <td>Calibration Date:</td> <td style="text-align: center;">20-Jan-12</td> <td></td> <td style="text-align: center;">1:30 PM</td> </tr> <tr> <td>Re-calibration Due:</td> <td style="text-align: center;">20-Jan-13</td> <td></td> <td></td> </tr> <tr> <td>Report Number:</td> <td style="text-align: center;">21559</td> <td></td> <td style="text-align: center;">-2</td> </tr> <tr> <td>Control Number:</td> <td style="text-align: center;">21559</td> <td></td> <td></td> </tr> </table> | Ambient Temperature: | 22.1 | | °C | Ambient Humidity: | 30.8 | | % RH | Ambient Pressure: | 100.1 | | kPa | Calibration Date: | 20-Jan-12 | | 1:30 PM | Re-calibration Due: | 20-Jan-13 | | | Report Number: | 21559 | | -2 | Control Number: | 21559 | | |
| the number of turns on each coil; | 10 | | No. | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| the radius of each coil, in meters; | 0.204 | | m | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| the current in the coils, in amperes.; | 0.08 | | A | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| <i>Helmholtz Coil Constant;</i> | 6.98 | | A/m/V | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| <i>Helmholtz Coil magnetic field;</i> | 5.90 | | A/m | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Probe Sensitivity at | 1000 | | Hz. | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| was | -60.50 | | dBV/A/m | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| | 0.944 | | mV/A/m | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Probe resistance | 903 | | Ohms | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Ambient Temperature: | 22.1 | | °C | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Ambient Humidity: | 30.8 | | % RH | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Ambient Pressure: | 100.1 | | kPa | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Calibration Date: | 20-Jan-12 | | 1:30 PM | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Re-calibration Due: | 20-Jan-13 | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Report Number: | 21559 | | -2 | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
| Control Number: | 21559 | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |



The above listed instrument meets or exceeds the tested manufacturer's specifications.

This Calibration is traceable through NIST test numbers: ,205342
 The expanded uncertainty of calibration: 0.30dB at 95% confidence level with a coverage factor of k=2.
 Graph represents Probes Frequency Response.



The above listed instrument was checked using calibration procedure documented in West Caldwell Calibration Laboratories Inc. procedure : **Rev. 5.0 Sept. 10, 2010 Doc. # 1038 HCRTEMC**
 Calibration was performed by West Caldwell Calibration Laboratories Inc. under Operating Procedures intended to implement the requirements of ISO10012-1, IEC Guide 25, ANSI/NCSL Z540-1, (MIL-STD-45662A) and ISO 9001:2008, ISO 17025

Cal. Date: 20-Jan-2012 1:30 PM Measurements performed by: 
 Calibrated on WCCL system type 9700 **Felix Christopher**
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| | | | |
|-------------------------------|---|-------------------------------|---|
| FCC ID: A3LSPHM950 |  | HAC (T-COIL) TEST REPORT |  |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | Reviewed by: Quality Manager Page 30 of 37 |

HCRTEMC_TEM-1130_Jan-20-2012

West Caldwell Calibration Laboratories Inc.

1575 State Route 96, Victor NY 14564
Tel. (585) 586-3900 FAX (585) 586-4327

Calibration Data Record

TEM Consulting LP Radial T Coil Probe for Model No.: Radial T Coil Probe Serial No.: TEM-1130

Company : Pctest Engineering Lab.

| Test | Function | Tolerance | Measured values | | | |
|------|--------------------------|-----------------------|-----------------|-------|---------|--|
| | | | Before | Out | Remarks | |
| 1.0 | Probe Sensitivity at | 1000 Hz. dBV/A/m | -60.50 | | | |
| 2.0 | Probe Level Linearity | | | | | |
| | | | 6 | 6.03 | | |
| | | Ref. (0 dB) | 0 | 0.00 | | |
| | | | -6 | -6.02 | | |
| | | -12 | -12.02 | | | |
| 3.0 | Probe Frequency Response | | | | | |
| | | | 100 | -20.0 | | |
| | | | 126 | -18.0 | | |
| | | | 158 | -15.9 | | |
| | | | 200 | -13.9 | | |
| | | | 251 | -11.9 | | |
| | | | 316 | -10.0 | | |
| | | | 398 | -8.0 | | |
| | | | 501 | -6.0 | | |
| | | | 631 | -4.0 | | |
| | | | 794 | -2.0 | | |
| | | | Ref. (0 dB) | 1000 | 0.0 | |
| | | | | 1259 | 2.0 | |
| | | | | 1585 | 4.0 | |
| | | | | 1995 | 6.0 | |
| | | | | 2512 | 7.9 | |
| | | 3162 | 9.9 | | | |
| | | 3981 | 11.9 | | | |
| | | 5012 | 13.9 | | | |
| | | 6310 | 15.9 | | | |
| | | 7943 | 18.0 | | | |
| | | 10000 | 20.1 | | | |



| Instruments used for calibration: | | | Date of Cal. | Traceability No. | Due Date |
|-----------------------------------|--------|--------------|--------------|------------------|-------------|
| HP | 34401A | S/N US360641 | 17-Oct-2011 | ,205342 | 16-Oct-2012 |
| HP | 34401A | S/N US361024 | 17-Oct-2011 | ,205342 | 16-Oct-2012 |
| HP | 33120A | S/N S3604371 | 17-Oct-2011 | ,205342 | 16-Oct-2012 |
| B&K | 2133 | S/N 1492410 | 4-Nov-2011 | 681/280411-11 | 4-Nov-2012 |

Cal. Date: 20-Jan-2012 1:30 PM
Calibrated on WCCL system type 9700

Tested by: Felix Christopher

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Rev. 5.0 Sept. 10, 2010 Doc. # 1038 HCRTEMC

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|-------------------------------|---|-------------------------------|---|---------------------------------|
| FCC ID: A3LSPHM950 |  | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | | Page 31 of 37 |

11. CONCLUSION



The measurements indicate that the wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.



| | | | | |
|--------------------------------------|---|--------------------------------------|---|--|
| FCC ID: A3LSPHM950 |  | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | Page 32 of 37 | |

12. REFERENCES

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|-------------------------------|--|-------------------------------|---|---------------------------------|
| FCC ID: A3LSPHM950 |  PCTEST Engineering Laboratory, Inc. | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | | Page 33 of 37 |

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| | | | | |
|--------------------------------------|--|--------------------------------------|---|--|
| FCC ID: A3LSPHM950 |  PCTEST Pulse Test Engineering Laboratory, Inc. | HAC (T-COIL) TEST REPORT |  | Reviewed by: Quality Manager |
| Filename: 0Y1206260859.A3L | Test Dates: 7/3/2012 | EUT Type: Portable Handset | Page 34 of 37 | |